

Development of a Modified Reconstruction Algorithm for 90-Degree Compton Scattering Imaging

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Abstract

A modified reconstruction algorithm has been developed for an X-ray luggage inspection modality based on 90 degree Compton scattering imaging. Incident photon energy E_0 of 122.1keV was used in simulated experiments with MCNP for 5x5x5 samples and the 90 degree Compton scattered photon energy E_1 is 98.6keV. In the $\mu(E_1)$ reconstruction calculation the least-squares solution was computed through Householder transformations applied in blocked form for the full $\mu(E_1)$ over-determined system equations of the side detector responses in the simulated experiments. In the $\mu(E_0)$ reconstruction calculation, instead of $\mu(E_0) = \mu(E_0)$ approximation which does not hold true for the source energy of this paper, the semi-empirical formula $\mu(E_0) = d * \mu(E_0) + e * \mu(E_1)$ was used and the least-squares solution was computed with the conjugate gradient method for $\mu(E_0)$ $\mu(E_0)$ system equations of the side and transmission detector responses and the semi-empirical formulae. Self attenuation correction factors in a simple form were applied in an iterative manner until the factors and reconstruction output are converged. The maximum errors of the reconstruction calculation for a sample with aluminum core and polyethylene matrix were -2.9% for $\mu(E_0)$, -1.0% for $\mu(E_1)$, and 1.9% for $\mu(E_0)$, showing good agreements with theoretical values. The maximum errors for the case with steel core and polyethylene matrix were -10.2% for $\mu(E_0)$, -3.3% for $\mu(E_1)$, and 20.3% for $\mu(E_0)$, indicating that this case with 3 cm steel rod would be a limiting case for the penetration ability of 122.1keV incident photons used in the inspection modality.